



ON Semiconductor®

## Advanced Power MOSFET

## IRFM120A

### FEATURES

### IEEE802.3af Compatible

- ☐ Avalanche Rugged Technology
- ☐ Rugged Gate Oxide Technology
- ☐ Lower Input Capacitance
- ☐ Improved Gate Charge
- ☐ Extended Safe Operating Area
- ☐ Lower Leakage Current : 10  $\mu$ A (Max.) @  $V_{DS} = 100V$
- ☐ Lower  $R_{DS(ON)}$  : 0.155  $\Omega$  (Typ.)

$$BV_{DSS} = 100 V$$

$$R_{DS(on)} = 0.2 \Omega$$

$$I_D = 2.3 A$$

### SOT-223



1. Gate 2. Drain 3. Source

### Absolute Maximum Ratings

| Symbol         | Characteristic  | Value        | Units         |
|----------------|---|--------------|---------------|
| $V_{DSS}$      | Drain-to-Source Voltage   | 100          | V             |
| $I_D$          | Continuous Drain Current ( $T_A=25^\circ C$ )                           | 2.3          | A             |
|                | Continuous Drain Current ( $T_A=70^\circ C$ )                           | 1.84         |               |
| $I_{DM}$       | Drain Current-Pulsed ①  | 18           | A             |
| $V_{GS}$       | Gate-to-Source Voltage  | $\pm 20$     | V             |
| $E_{AS}$       | Single Pulsed Avalanche Energy ②  | 123          | mJ            |
| $I_{AR}$       | Avalanche Current ①   | 2.3          | A             |
| $E_{AR}$       | Repetitive Avalanche Energy ①   | 0.24         | mJ            |
| $dv/dt$        | Peak Diode Recovery $dv/dt$ ③   | 6.5          | V/ns          |
| $P_D$          | Total Power Dissipation ( $T_A=25^\circ C$ ) *                          | 2.4          | W             |
|                | Linear Derating Factor *  | 0.019        | W/ $^\circ C$ |
| $T_J, T_{STG}$ | Operating Junction and Storage Temperature Range                        | - 55 to +150 | $^\circ C$    |
| $T_L$          | Maximum Lead Temp. for Soldering Purposes, 1/8" from case for 5-seconds | 300          |               |

### Thermal Resistance

| Symbol          | Characteristic        | Typ. | Max. | Units        |
|-----------------|-----------------------|------|------|--------------|
| $R_{\theta JA}$ | Junction-to-Ambient * | --   | 52   | $^\circ C/W$ |

\* When mounted on the minimum pad size recommended (PCB Mount).

**Electrical Characteristics** ( $T_A=25^\circ\text{C}$  unless otherwise specified)

| Symbol                 | Characteristic                          | Min. | Typ. | Max. | Units               | Test Condition   |
|------------------------|---|------|------|------|---------------------|--|
| $BV_{DSS}$             | Drain-Source Breakdown Voltage          | 100  | --   | --   | V                   | $V_{GS}=0V, I_D=250\mu A$  |
| $\Delta BV/\Delta T_J$ | Breakdown Voltage Temp. Coeff.          | --   | 0.12 | --   | V/ $^\circ\text{C}$ | $I_D=250\mu A$ <b>See Fig 7</b>  |
| $V_{GS(th)}$           | Gate Threshold Voltage                  | 2.0  | --   | 4.0  | V                   | $V_{DS}=5V, I_D=250\mu A$  |
| $I_{GSS}$              | Gate-Source Leakage, Forward            | --   | --   | 100  | nA                  | $V_{GS}=20V$   |
|                        | Gate-Source Leakage, Reverse            | --   | --   | -100 | nA                  | $V_{GS}=-20V$  |
| $I_{DSS}$              | Drain-to-Source Leakage Current         | --   | --   | 1    | $\mu A$             | $V_{DS}=30V$ ⑥   |
|                        |   | --   | --   | 10   |                     | $V_{DS}=100V$  |
|                        |   | --   | --   | 100  |                     | $V_{DS}=80V, T_A=125^\circ\text{C}$  |
| $R_{DS(on)}$           | Static Drain-Source On-State Resistance | --   | --   | 0.2  | $\Omega$            | $V_{GS}=10V, I_D=1.15A$ ④  |
| $g_{fs}$               | Forward Transconductance                | --   | 3.12 | --   | S                   | $V_{DS}=40V, I_D=1.15A$ ④  |
| $C_{iss}$              | Input Capacitance                       | --   | 370  | 480  | pF                  | $V_{GS}=0V, V_{DS}=25V, f=1\text{MHz}$<br><b>See Fig 5</b>                   |
| $C_{oss}$              | Output Capacitance                      | --   | 95   | 110  |                     |  |
| $C_{rss}$              | Reverse Transfer Capacitance            | --   | 38   | 45   |                     |  |
| $t_{d(on)}$            | Turn-On Delay Time                      | --   | 14   | 40   | ns                  | $V_{DD}=50V, I_D=9.2A,$<br>$R_G=18\Omega$<br><b>See Fig 13</b> ④ ⑤           |
| $t_r$                  | Rise Time                               | --   | 14   | 40   |                     |  |
| $t_{d(off)}$           | Turn-Off Delay Time                     | --   | 36   | 90   |                     |  |
| $t_f$                  | Fall Time                               | --   | 28   | 70   |                     |  |
| $Q_g$                  | Total Gate Charge                       | --   | 16   | 22   | nC                  | $V_{DS}=80V, V_{GS}=10V,$<br>$I_D=9.2A$<br><b>See Fig 6 &amp; Fig 12</b> ④ ⑤ |
| $Q_{gs}$               | Gate-Source Charge                      | --   | 2.7  | --   |                     |  |
| $Q_{gd}$               | Gate-Drain("Miller") Charge             | --   | 7.8  | --   |                     |  |

**Source-Drain Diode Ratings and Characteristics**

| Symbol   | Characteristic            | Min. | Typ. | Max. | Units   | Test Condition                              |
|----------|---------------------------|------|------|------|---------|---|
| $I_S$    | Continuous Source Current | --   | --   | 2.3  | A       | Integral reverse pn-diode in the MOSFET     |
| $I_{SM}$ | Pulsed-Source Current ①   | --   | --   | 18   |         |   |
| $V_{SD}$ | Diode Forward Voltage ④   | --   | --   | 1.5  | V       | $T_J=25^\circ\text{C}, I_S=2.3A, V_{GS}=0V$ |
| $t_{rr}$ | Reverse Recovery Time     | --   | 98   | --   | ns      | $T_J=25^\circ\text{C}, I_F=9.2A$            |
| $Q_{rr}$ | Reverse Recovery Charge   | --   | 0.34 | --   | $\mu C$ | $di_F/dt=100A/\mu s$ ④                      |

**Notes ;**

- ① Repetitive Rating : Pulse Width Limited by Maximum Junction Temperature
- ②  $L=35\text{mH}, I_{AS}=2.3A, V_{DD}=25V, R_G=27\Omega$ , Starting  $T_J=25^\circ\text{C}$
- ③  $I_{SD}\leq 9.2A, di/dt\leq 300A/\mu s, V_{DD}\leq BV_{DSS}$ , Starting  $T_J=25^\circ\text{C}$
- ④ Pulse Test : Pulse Width =  $250\mu s$ , Duty Cycle  $\leq 2\%$
- ⑤ Essentially Independent of Operating Temperature
- ⑥ Adjusted for Cisco

Fig 1. Output Characteristics

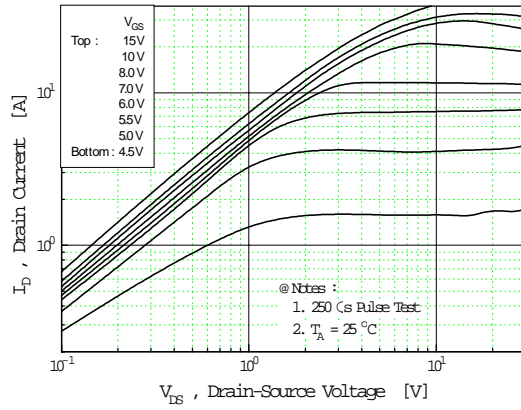


Fig 2. Transfer Characteristics

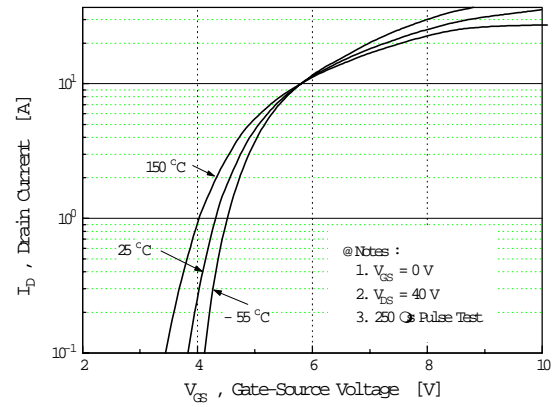


Fig 3. On-Resistance vs. Drain Current

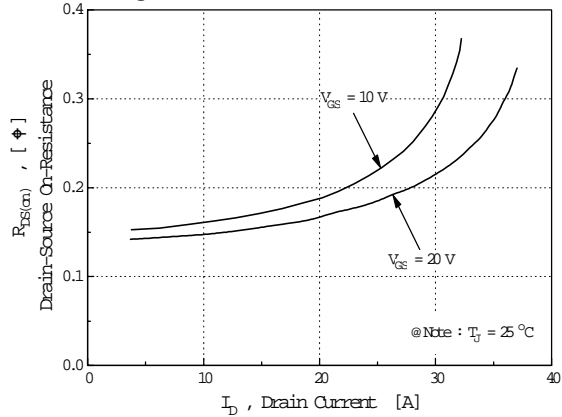


Fig 4. Source-Drain Diode Forward Voltage

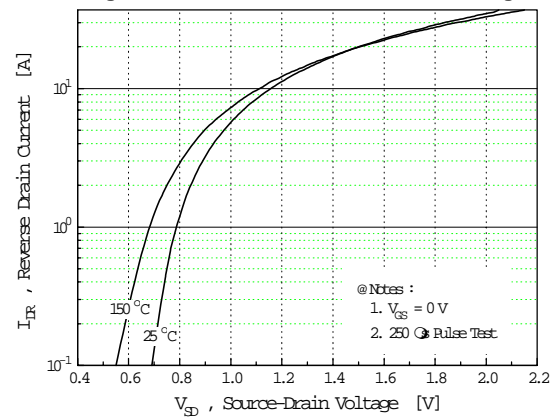


Fig 5. Capacitance vs. Drain-Source Voltage

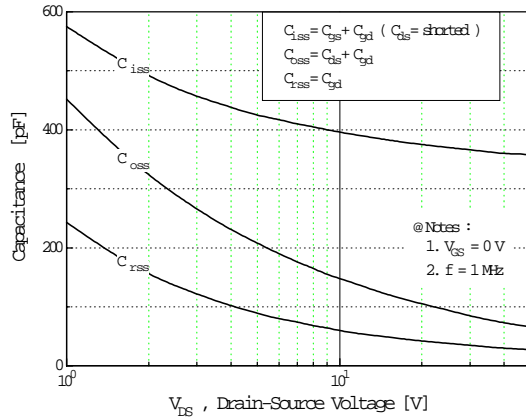


Fig 6. Gate Charge vs. Gate-Source Voltage

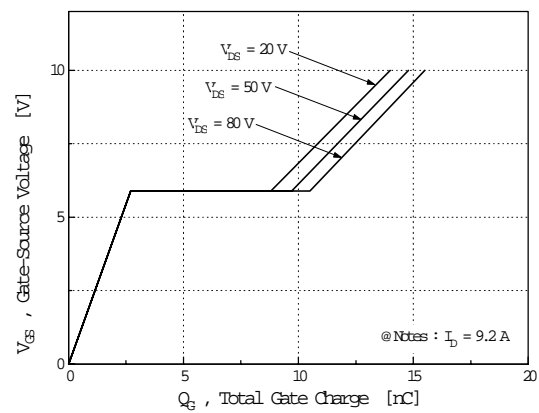


Fig 7. Breakdown Voltage vs. Temperature

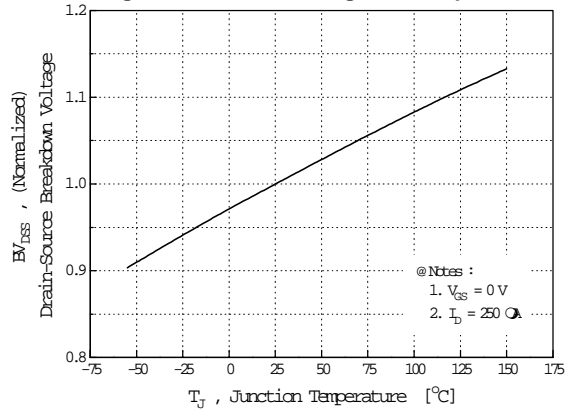


Fig 8. On-Resistance vs. Temperature

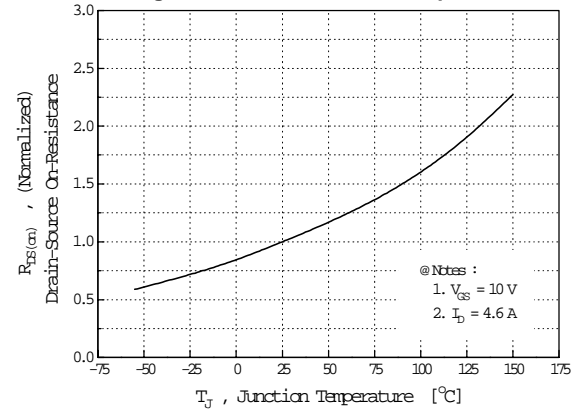


Fig 9. Max. Safe Operating Area

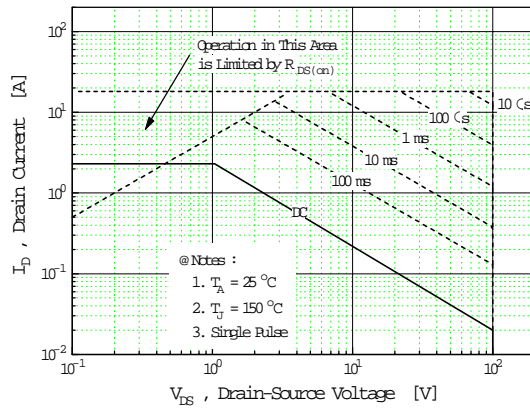


Fig 10. Max. Drain Current vs. Ambient Temperature

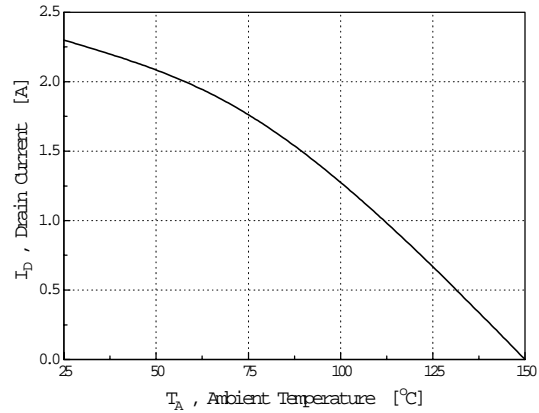


Fig 11. Thermal Response

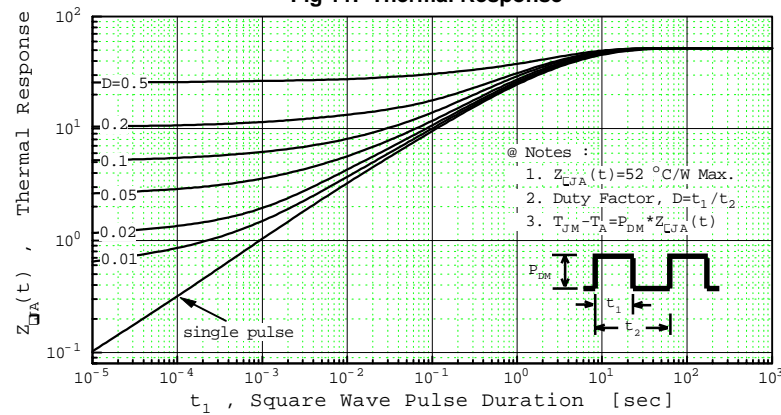


Fig 12. Gate Charge Test Circuit &amp; Waveform

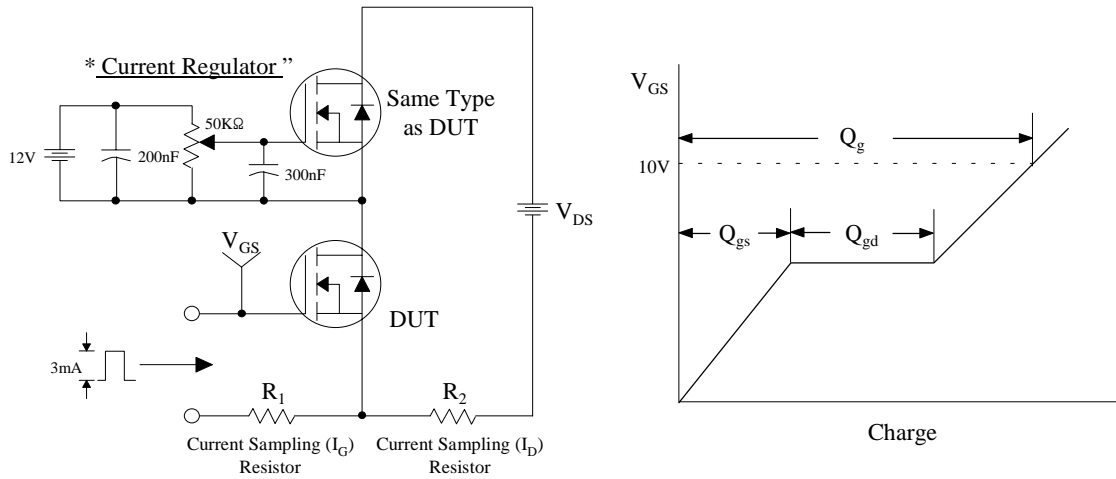


Fig 13. Resistive Switching Test Circuit &amp; Waveforms

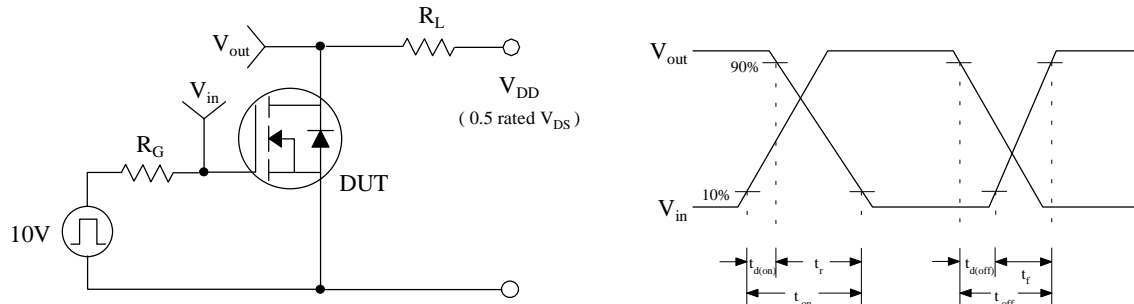


Fig 14. Unclamped Inductive Switching Test Circuit &amp; Waveforms

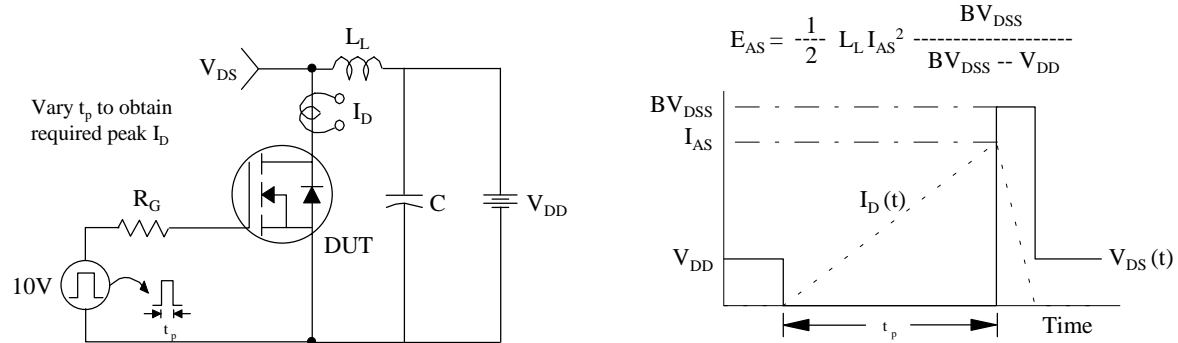
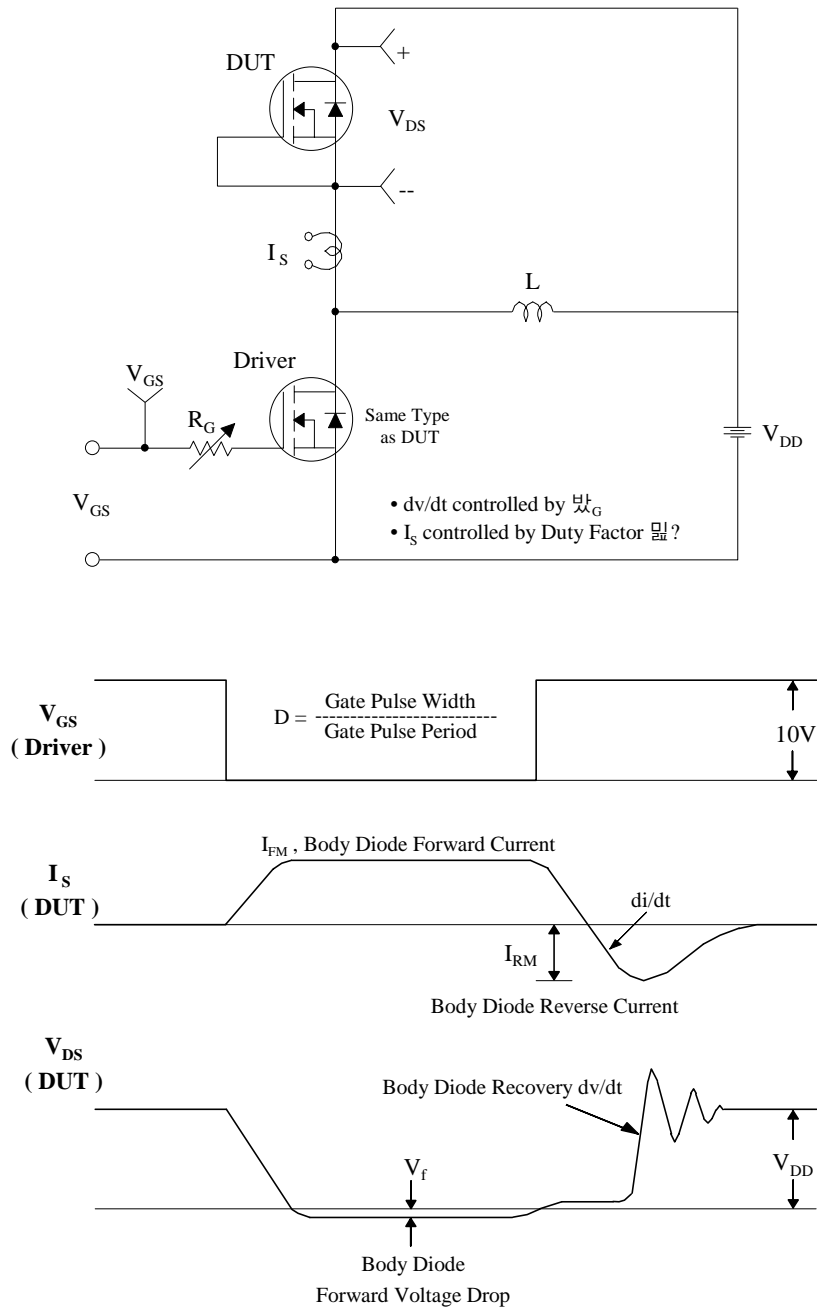


Fig 15. Peak Diode Recovery dv/dt Test Circuit &amp; Waveforms



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